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| Notice of References Cited | Application/Control No. 10/582,717 | Applicant(s)/Patent Under Reexamination TOYODA ET AL. | |
| | Examiner Vanessa Velasquez | Art Unit 1793 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|-----------------|----------------|
| | N | JP2002-266022 | 09-2002 | Japan | HASEGAWA et al. | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
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